

<b>Notice of References Cited</b>	Application/Control No. 10/591,534	Applicant(s)/Patent Under Reexamination HAUKE ET AL.	
	Examiner Dwan A. Gerido, Ph.D.	Art Unit 1797	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,302,480	11-1981	Fischer et al.	435/40.5
*	B	US-3,498,860	03-1970	PICKETT JOHN E P	156/57
*	C	US-4,011,350	03-1977	Markovits et al.	427/2.13
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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